July 2008



FDMS8692

N-Channel PowerTrench[®] MOSFET 30V, 28A, $9.0m\Omega$

Features

- Max $r_{DS(on)} = 9.0 \text{m}\Omega$ at $V_{GS} = 10 \text{V}$, $I_D = 12 \text{A}$
- Max $r_{DS(on)} = 14.0 \text{m}\Omega$ at $V_{GS} = 4.5 \text{V}$, $I_D = 10.5 \text{A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- MSL1 robust package design
- RoHS Compliant

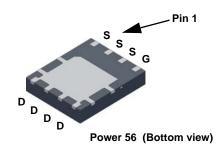


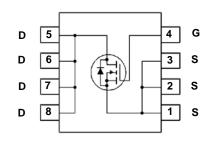
General Description

The FDMS8692 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{\text{DS}(on)}$ while maintaining excellent switching performance.

Applications

- Low Side for Synchronous Buck to Power Core Processor
- Secondary Side Synchronous Rectifier
- Low Side Switch in POL DC/DC Converter
- Oring FET/ Load Switch





MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25°C		28	
	-Continuous (Silicon limited)	T _C = 25°C		48	^
'D	-Continuous	T _A = 25°C	(Note 1a)	12	Α
	-Pulsed			120	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	72	mJ
Б	Power Dissipation	T _C = 25°C		41	W
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		3.0	°C/W
R _{e.IA}	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8692	FDMS8692	Power 56	13"	12mm	3000units

Electrical Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24V, V_{GS} = 0V$			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-5.4		mV/°C
		$V_{GS} = 10V, I_D = 12A$		7.0	9.0	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5, I_D = 10.5A$		10.5	14.0	mΩ
		$V_{GS} = 10V$, $I_D = 12A$, $T_J = 125$ °C		10.0	13.0	
9 _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 12A$		58		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45V V 0V	950	1265	pF
C _{oss}	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1MHz	515	685	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	85	130	pF
R_g	Gate Resistance	f = 1MHz	1.0	4.0	Ω

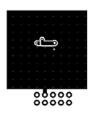
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		$V_{DD} = 15V, I_{D} = 12A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$		9	18	ns
t _r	Rise Time	$V_{DD} = 15V, I_D = 12V$			3	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, K _{GEN}			19	34	ns
t _f	Fall Time				2	10	ns
Q_g	Total Gate Charge	V _{GS} = 0V to 10V			15	21	nC
Qg	Total Gate Charge	$V_{GS} = 0V \text{ to } 5V$	$V_{DD} = 15V,$ $I_{D} = 12A$		8	11	nC
Q _{gs}	Gate to Source Charge		1 _D = 12A		2.7		nC
Q_{gd}	Gate to Drain "Miller" Charge				2.1		nC

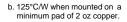
Drain-Source Diode Characteristics

V _{SD} Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.1A$ (Note 2)		0.7	1.2	V	
V_{SD}	Source to Drain Diode Porward voltage	$V_{GS} = 0V, I_{S} = 12A$		0.8	1.2	٧
t _{rr}	Reverse Recovery Time	L = 124 di/dt = 1004/		29	47	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 12A$, di/dt = 100A/ μ s		14	25	nC

^{1.} R_{0,1A} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,1C} is determined by the user's board design.



a. 50°C/W when mounted on a 1in² pad of 2 oz copper.





^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. Starting T_J = 25°C, L = 0.3mH, I_{AS} = 22A, V_{DD} = 30V, V_{GS} = 10V.

Typical Characteristics T_J = 25°C unless otherwise noted

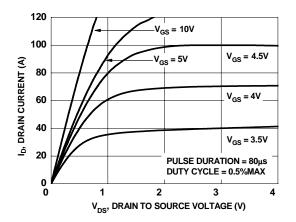


Figure 1. On-Region Characteristics

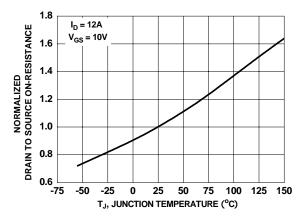


Figure 3. Normalized On-Resistance vs Junction Temperature

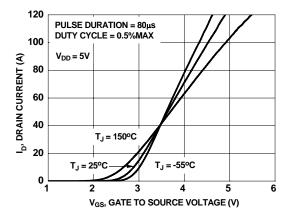


Figure 5. Transfer Characteristics

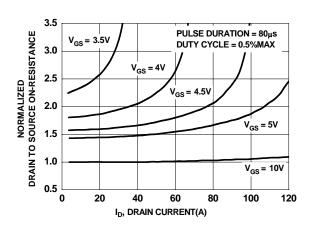


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

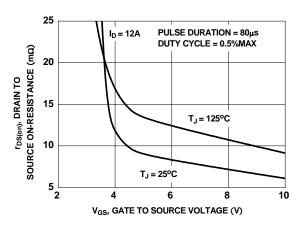


Figure 4. On-Resistance vs Gate to Source Voltage

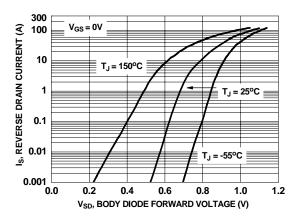


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

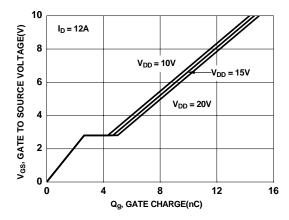


Figure 7. Gate Charge Characteristics

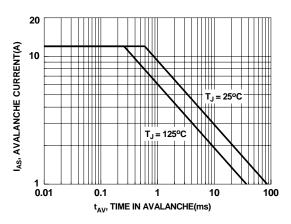


Figure 9. Unclamped Inductive Switching Capability

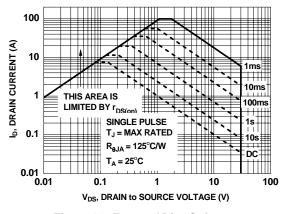


Figure 11. Forward Bias Safe Operating Area

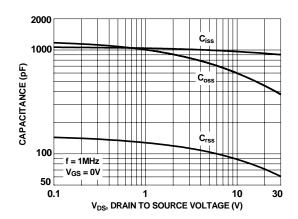


Figure 8. Capacitance vs Drain to Source Voltage

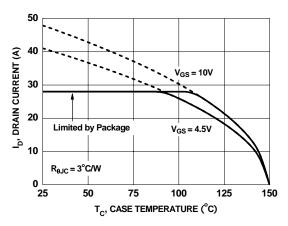


Figure 10. Maximum Continuous Drain Current vs Case Temperature

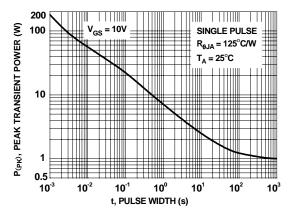


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

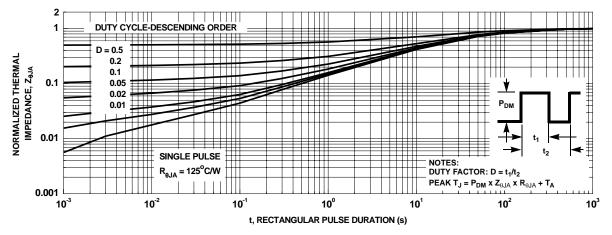
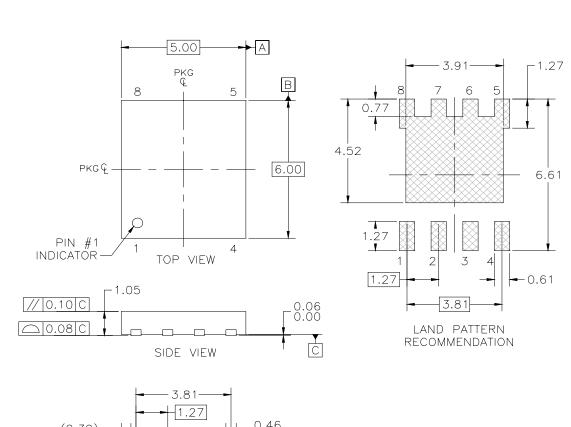
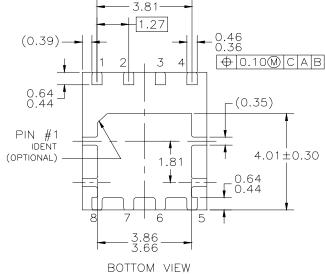


Figure 13. Transient Thermal Response Curve





NOTES: UNLESS OTHERWISE SPECIFIED

- ALL DIMENSIONS ARE IN MILLIMETERS.
- NO JEDEC REFERENCE AS OF FEBRUARY 2006 DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994

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